



# RADIO TEST REPORT

Test Report No. : 11145757H-B-R1

**Applicant** : Mitsubishi Electric Corporation Himeji Works  
**Type of Equipment** : Smart Keyless System (Hand Unit)  
**Model No.** : SKEA7D-02  
**Test regulation** : FCC Part 15 Subpart C: 2016  
**FCC ID** : WAZSKEA7D02  
**Test Result** : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. This report is a revised version of 11145757H-B. 11145757H-B is replaced with this report.

**Date of test:** May 15 and 16, 2016

**Representative test engineer:** *K. Kawamura*  
Keisuke Kawamura  
Engineer  
Consumer Technology Division

**Approved by:** *M. Imura*  
Motoya Imura  
Engineer  
Consumer Technology Division



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.  
\*As for the range of Accreditation in NVLAP, you may refer to the WEB address,  
[http://japan.ul.com/resources/emc\\_accredited/](http://japan.ul.com/resources/emc_accredited/)



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## **SECTION 1: Customer information**

Company Name : Mitsubishi Electric Corporation Himeji works  
Address : 840 Chiyoda-machi Himeji Hyogo, 670-8677, Japan  
Telephone Number : +81-79-298-7363  
Facsimile Number : +81-79-298-9929  
Contact Person : Shinichi Furuta

## **SECTION 2: Equipment under test (E.U.T.)**

### **2.1 Identification of E.U.T.**

Type of Equipment : Smart Keyless System (Hand Unit)  
Model No. : SKEA7D-02  
Serial No. : Refer to Clause 4.2  
Rating : DC 3.0V  
Receipt Date of Sample : May 12, 2016  
Country of Mass-production : Thailand  
Condition of EUT : Production prototype  
(Not for Sale: This sample is equivalent to mass-produced items.)  
Modification of EUT : No Modification by the test lab

### **2.2 Product Description**

Model No: SKEA7D-02 (referred to as the EUT in this report) is the Smart Keyless System (Hand Unit).  
The clock frequency of EUT is 27.6 MHz (Crystal).

### **Radio Specification**

#### **RF Part**

Equipment Type : Transmitter  
Frequency band : 315 MHz  
Type of modulation : ASK  
Bandwidth : 2.5 kHz  
Antenna Type : PCB Pattern  
Method of Frequency Generation : Crystal  
Operating voltage (inner) : DC +3.0 V

#### **LF Part \***

Type of Receiver : Receiver  
Frequency of operation : 125 kHz  
Antenna Type : Inductive  
Method of Frequency Generation : Crystal  
Operating voltage (inner) : DC +3.0 V

\* The test of receiver part was performed separately from this test report, and the conformability is confirmed.  
LF Part test report No. 11145757H-D (FCC15B).

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## **UL Japan, Inc.**

### **Ise EMC Lab.**

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## **SECTION 3: Test specification, procedures & results**

### **3.1 Test Specification**

Test Specification : FCC Part 15 Subpart C  
FCC part 15 final revised on April 6, 2016.

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators  
Section 15.231 Periodic operation in the band 40.66 - 40.70MHz  
and above 70MHz

\* Also the EUT complies with FCC Part 15 Subpart B.

### **3.2 Procedures and results**

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.207	N/A	N/A *1)	-
	IC: RSS-Gen 8.8	IC: RSS-Gen 8.8			
Automatically Deactivate	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(a)(1)	N/A	Complied	Radiated
	IC: -	IC: RSS-210 A1.1.1			
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(b)	4.0 dB 315 MHz Horizontal, PK with Duty factor	Complied	Radiated
	IC: RSS-Gen 6.12	IC: RSS-210 A1.1.2			
Electric Field Strength of Spurious Emission	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.205 Section 15.209 Section 15.231(b)	4.6 dB 2835 MHz Vertical, PK with Duty factor	Complied	Radiated
	IC: RSS-Gen 6.13	IC: RSS-210 A1.1.2, 2.5.1 RSS-Gen 8.9			
-20dB Bandwidth	FCC: ANSI C63.10:2013 6 Standard test methods	FCC: Section 15.231(c)	N/A	Complied	Radiated
	IC: -	IC: Reference data			

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.  
\*1) The test is not applicable since the EUT does not have AC Mains.

#### **FCC 15.31 (e)**

This test was performed with the New Battery (DC 3.0 V) during the tests. Therefore, the EUT complies with the requirement.

#### **FCC Part 15.203 Antenna requirement**

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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### 3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	IC: RSS-Gen 6.6	IC: RSS-210 A1.1.3	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

### 3.4 Uncertainty

#### EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test distance	Radiated emission (±dB)
	9 kHz - 30 MHz
3m	3.8 dB
10m	3.7 dB

\*Measurement distance

Polarity	Radiated emission (Below 1GHz)			
	(3 m*)(±dB)		(10 m*)(±dB)	
	30 – 200 MHz	200 – 1000MHz	30 – 200 MHz	200 – 1000MHz
Horizontal	4.9 dB	5.2 dB	4.9 dB	5.0 dB
Vertical	4.6 dB	5.9 dB	5.0 dB	5.0 dB

Radiated emission				
(3 m*)(±dB)	(1 m*)(±dB)	(0.5 m*)(±dB)	(10 m*)(±dB)	
1 – 6GHz	6 – 18GHz	10 – 26.5 GHz	26.5 – 40GHz	1 -18 GHz
5.1 dB	5.3 dB	5.1 dB	5.1 dB	5.3 dB

\* Measurement distance

#### Radiated emission test(3 m)

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

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### 3.5 Test Location

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	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

\* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Test data, Test instruments, and Test set up.

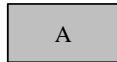
Refer to APPENDIX.

## **SECTION 4: Operation of E.U.T. during testing**

### **4.1 Operating Modes**

<b>Test Item*</b>	<b>Mode</b>
Automatically Deactivate	Normal use mode 315 MHz
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20dB & 99% Occupied Bandwidth Duty Cycle	Transmitting mode (Tx) 315 MHz *1), *2)
<p>* The system was configured in typical fashion (as a customer would normally use it) for testing.  *1) The software of this mode is the same as one of normal product, except that EUT continues to transmit when transmitter button is being pressed (For Normal use mode, EUT stops to transmit in a given time, even if transceiver button is being pressed.)  End users cannot change the settings of the output power of the product.  *2) Hand Unit has two functions; Smart keyless function and Normal keyless function (Hand Unit function).  The difference of these functions is the gap of operation timing.  There is no difference in Output power of these functions (It was confirmed in pre check.).  Therefore the test was performed with Normal keyless function.</p>	

### **4.2 Configuration and peripherals**



\* Test data was taken under worse case conditions.

#### **Description of EUT**

<b>No.</b>	<b>Item</b>	<b>Model number</b>	<b>Serial number</b>	<b>Manufacturer</b>	<b>Remarks</b>
A	Smart Keyless System (Hand Unit)	SKEA7D-02	20160511-T1 (No.6) *1) 20160511-T2 (No.14) *2)	Mitsubishi Electric Corporation Himeji works	EUT

\*1) Used for Transmitting mode.

\*2) Used for Normal use mode.

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**SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)**

**Test Procedure and conditions**

[For below 1GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Photographs of the set up are shown in Appendix 3.

**[Transmitting mode]**

**(Below 30 MHz)**

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

**(Above 30 MHz)**

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3 m.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

**Test Antennas are used as below;**

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.1 kHz	9.1 kHz	120 kHz	PK: S/A: RBW 1 MHz, VBW: 3 MHz

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

\*The result is rounded off to the second decimal place, so some differences might be observed.

**Measurement range : 9 kHz - 3.2 GHz**  
**Test data : APPENDIX**  
**Test result : Pass**

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## **SECTION 6: Automatically deactivate**

### **Test Procedure**

The measurement was performed with Electric field strength using a spectrum analyzer.

**Test data** : APPENDIX  
**Test result** : Pass

## **SECTION 7: -20 dB and 99 % Occupied Bandwidth**

### **Test Procedure**

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	300 kHz	3 kHz	9.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer

\*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100 %.  
Peak hold was applied as Worst-case measurement.

**Test data** : APPENDIX  
**Test result** : Pass

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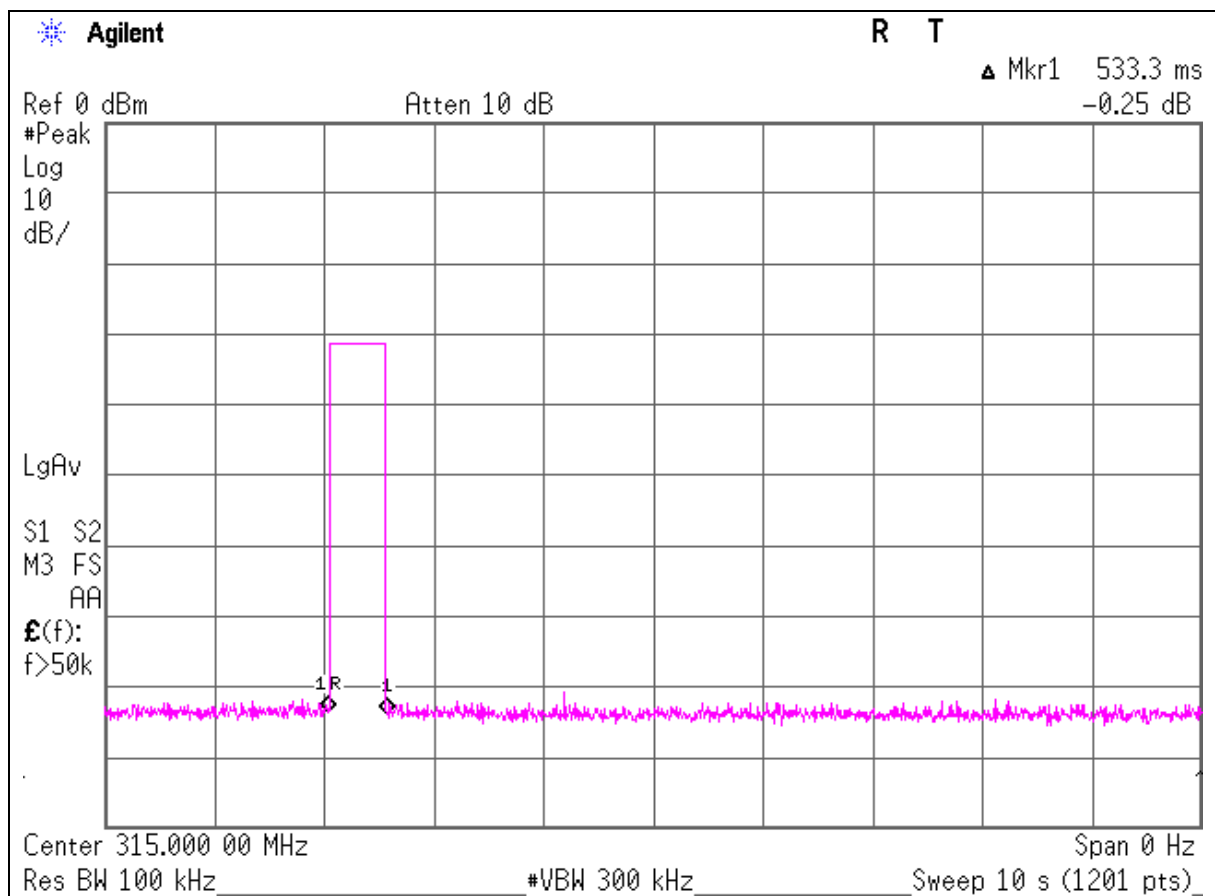
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**APPENDIX 1: Test data**

**Automatically deactivate**

Test place Ise EMC Lab. No.11 Measurement Room  
Report No. 11145757H  
Date 05/15/2016  
Temperature/ Humidity 22 deg. C / 48% RH  
Engineer Keisuke Kawamura  
Mode Normal use mode 315MHz

Time of Transmitting [sec]	Limit [sec]	Result
0.5333	5.00	Pass



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## Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place : Ise EMC Lab. No.2 Semi Anechoic Chamber  
Report No. : 11145757H  
Date : 05/16/2016  
Temperature/ Humidity : 24 deg. C / 62% RH  
Engineer : Keisuke Kawamura  
Mode : Transmitting mode 315MHz

**PK**

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
315.000	PK	76.4	72.9	13.8	8.9	27.5	-	71.6	68.1	95.6	24.0	27.5	Carrier
630.000	PK	31.1	30.7	19.1	10.2	28.3	-	32.1	31.7	75.6	43.5	43.9	Outside
945.000	PK	29.9	30.3	22.1	11.3	27.2	-	36.1	36.5	75.6	39.5	39.1	Outside
1260.000	PK	49.8	49.3	25.2	3.8	35.8	-	43.0	42.5	75.6	32.6	33.1	Outside
1575.000	PK	51.5	52.4	25.8	4.0	35.4	-	45.9	46.8	73.9	28.0	27.1	Inside
1890.000	PK	45.3	45.3	26.9	4.2	35.2	-	41.2	41.2	75.6	34.4	34.4	Outside
2205.000	PK	48.0	47.9	27.4	4.3	34.9	-	44.8	44.7	73.9	29.1	29.2	Inside
2520.000	PK	45.6	45.1	27.7	4.5	34.7	-	43.1	42.6	75.6	32.5	33.0	Outside
2835.000	PK	50.9	51.1	28.1	4.6	34.5	-	49.1	49.3	73.9	24.8	24.6	Inside
3150.000	PK	43.8	44.3	28.4	4.8	34.2	-	42.8	43.3	75.6	32.8	32.3	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier)

**PK with Duty factor**

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
315.000	PK	76.4	72.9	13.8	8.9	27.5	0.0	71.6	68.1	75.6	4.0	7.5	Carrier
630.000	PK	31.1	30.7	19.1	10.2	28.3	0.0	32.1	31.7	55.6	23.5	23.9	Outside
945.000	PK	29.9	30.3	22.1	11.3	27.2	0.0	36.1	36.5	55.6	19.5	19.1	Outside
1260.000	PK	49.8	49.3	25.2	3.8	35.8	0.0	43.0	42.5	55.6	12.6	13.1	Outside
1575.000	PK	51.5	52.4	25.8	4.0	35.4	0.0	45.9	46.8	53.9	8.0	7.1	Inside
1890.000	PK	45.3	45.3	26.9	4.2	35.2	0.0	41.2	41.2	55.6	14.4	14.4	Outside
2205.000	PK	48.0	47.9	27.4	4.3	34.9	0.0	44.8	44.7	53.9	9.1	9.2	Inside
2520.000	PK	45.6	45.1	27.7	4.5	34.7	0.0	43.1	42.6	55.6	12.5	13.0	Outside
2835.000	PK	50.9	51.1	28.1	4.6	34.5	0.0	49.1	49.3	53.9	4.8	4.6	Inside
3150.000	PK	43.8	44.3	28.4	4.8	34.2	0.0	42.8	43.3	55.6	12.8	12.3	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator) - Gain(Amplifier) + Duty factor

\*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Sample calculation:

Result of PK = Reading + Ant Factor + Loss (Cable + Attenuator +Distance factor) - Gain (Amplifier)

Result of PK with Duty factor = Reading + Ant Factor + Loss (Cable + Attenuator +Distance factor) - Gain (Amplifier) + Duty factor

For above 1GHz : Distance Factor:  $20 \times \log(3.75 \text{ m}/3.0 \text{ m}) = 1.94 \text{ dB}$

\*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.

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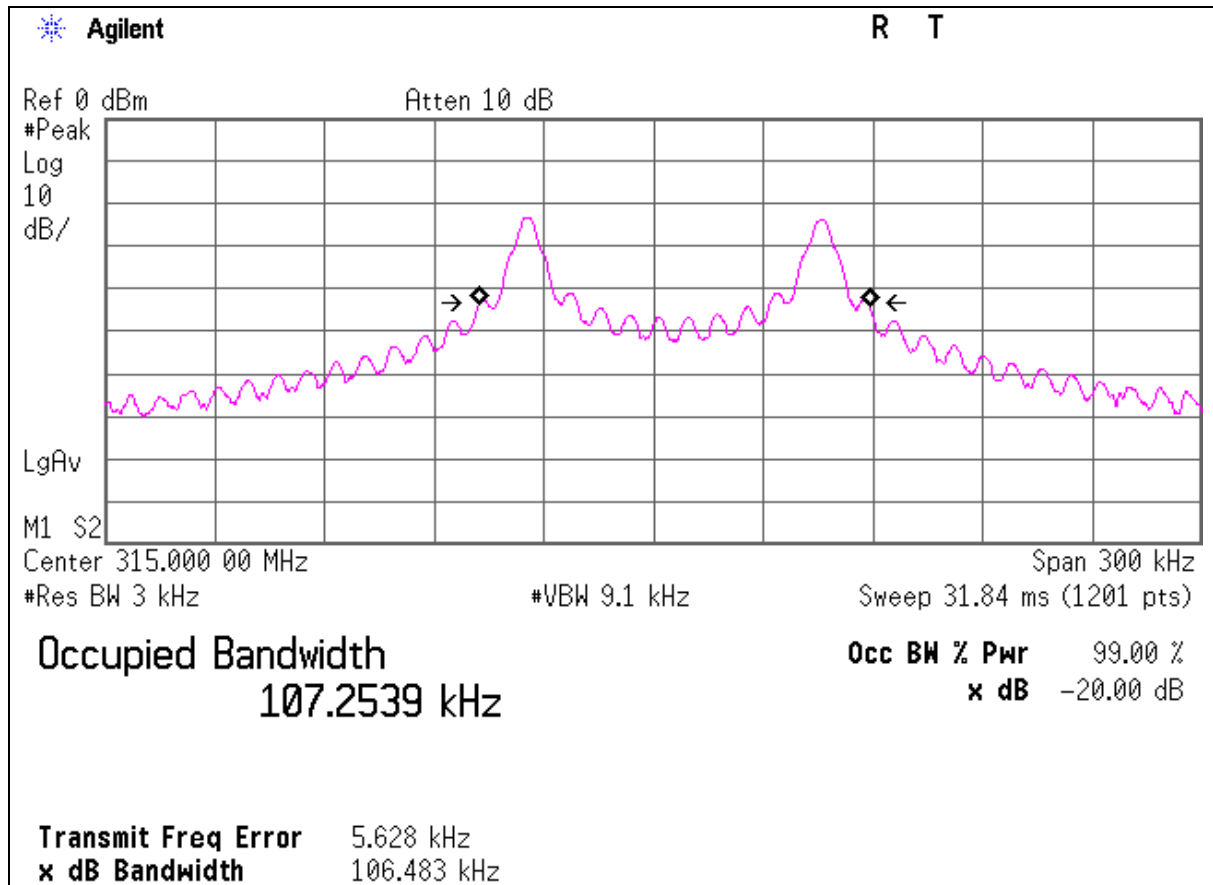
**-20dB and 99% Occupied Bandwidth**

Test place Ise EMC Lab. No.11 Measurement Room  
Report No. 11145757H  
Date 05/15/2016  
Temperature/ Humidity 22 deg. C / 48% RH  
Engineer Keisuke Kawamura  
Mode Transmitting mode 315MHz

Bandwidth Limit : Fundamental Frequency       $315 \text{ MHz} \times 0.25\% = 787.50 \text{ kHz}$

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
106.48	787.50	Pass

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
107.25	787.50	Pass



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## **APPENDIX 2: Test Instruments**

### **EMI test equipment**

<b>Control No.</b>	<b>Instrument</b>	<b>Manufacturer</b>	<b>Model No</b>	<b>Serial No</b>	<b>Test Item</b>	<b>Calibration Date * Interval(month)</b>
MOS-19	Thermo-Hygrometer	Custom	CTH-201	0001	RE	2015/12/08 * 12
MSA-13	Spectrum Analyzer	Agilent	E4440A	MY46185823	RE	2015/06/02 * 12
MAEC-02	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	RE	2015/07/01 * 12
MOS-22	Thermo-Hygrometer	Custom	CTH-201	0003	RE	2016/01/21 * 12
MJM-14	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MTR-03	Test Receiver	Rohde & Schwarz	ESCI	100300	RE	2015/10/11 * 12
MBA-03	Biconical Antenna	Schwarzbeck	BBA9106	1915	RE	2015/10/11 * 12
MLA-21	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-190	RE	2016/01/30 * 12
MCC-12	Coaxial Cable	Fujikura/Agilent	-	-	RE	2016/02/08 * 12
MAT-07	Attenuator(6dB)	Weinschel Corp	2	BK7970	RE	2015/11/10 * 12
MPA-09	Pre Amplifier	Agilent	8447D	2944A10845	RE	2015/09/04 * 12
MMM-01	Digital Tester	Fluke	FLUKE 26-3	78030611	RE	2015/08/19 * 12
MHA-06	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	254	RE	2016/02/29 * 12
MCC-168	Microwave Cable	Junkosha	MWX221	1408S016(1m) / 1409S492(5m)	RE	2015/09/24 * 12
MPA-10	Pre Amplifier	Agilent	8449B	3008A02142	RE	2016/01/19 * 12
MLPA-07	Loop Antenna	UL Japan	-	-	RE	Pre Check

**The expiration date of the calibration is the end of the expired month.**

**All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.**

**As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.**

**Test Item:**

**RE: Radiated emission, 99% Occupied Bandwidth, -20dB bandwidth, and Automatically deactivate tests**

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